

• General Description

It combines advanced trench MOSFET technology with a low resistance package to provide extremely low  $R_{DS(ON)}$ .

• Features

- AEC-Q101 Qualified
- Low  $R_{DS(ON)}$  to minimize conductive loss
- Low Gate Charge for fast switching
- Low Thermal resistance

• Application

- BLDC Motor driver
- DC-DC
- Battery protection

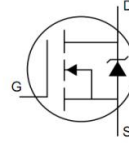
• Ordering Information:

|                           |              |
|---------------------------|--------------|
| Part NO.                  | ZMSA016N04HD |
| Marking                   | ZMS016N04H   |
| Packing Information       | REEL TAPE    |
| Basic ordering unit (pcs) | 2500         |

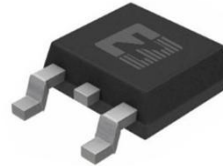
• Absolute Maximum Ratings ( $T_C=25^\circ\text{C}$ )

| Parameter                        | Symbol    | Conditions  | Min.    | Max. | Unit             |
|----------------------------------|-----------|---|---------|------|------------------|
| Drain-Source Voltage             | $V_{DS}$  |   | 40      |      | V                |
| Gate-Source Voltage <sup>①</sup> | $V_{GS}$  |   | -20     | 20   | V                |
| Continuous Drain Current         | $I_D$     | $T_C=25^\circ\text{C}$  |         | 110  | A                |
|                                  | $I_D$     | $T_C=75^\circ\text{C}$  |         | 110  | A                |
|                                  | $I_D$     | $T_C=100^\circ\text{C}$   |         | 98   | A                |
| Pulsed Drain Current             | $I_{DM}$  | Pulsed; $t_p \leq 10 \mu\text{s}$ ; $T_{mb} = 25^\circ\text{C}$ ; |         | 440  | A                |
| Total Power Dissipation          | $P_D$     | $T_C=25^\circ\text{C}$  |         | 75   | W                |
| Total Power Dissipation          | $P_D$     | $T_A=25^\circ\text{C}$  |         | 2.4  | W                |
| Operating Junction Temperature   | $T_J$     |   | -55     | 175  | $^\circ\text{C}$ |
| Storage Temperature              | $T_{STG}$ |   | -55     | 175  | $^\circ\text{C}$ |
| Single Pulse Avalanche Energy    | $E_{AS}$  | $L=0.1\text{mH}$ , $V_{GS}=10\text{V}$ , $R_g=25\Omega$ ,         |         | 320  | mJ               |
|                                  |           | $L=0.5\text{mH}$ , $V_{GS}=10\text{V}$ , $R_g=25\Omega$ ,         |         | 608  | mJ               |
| ESD Level (HBM)                  |           |   | CLASS 2 |      |                  |

• Product Summary



$V_{DS} = 40\text{V}$   
 $R_{DS(ON)} = 1.6\text{m}\Omega$   
 $I_D = 110\text{A}$



TO-252



**•Thermal resistance**

| Parameter                            | Symbol                       | Min. | Typ. | Max. | Unit |
|--------------------------------------|------------------------------|------|------|------|------|
| Thermal resistance, junction - case  | $R_{thJC}$                   |      | -    | 2    | °C/W |
| Thermal resistance, junction-ambient | $R_{thJA}^{\textcircled{2}}$ |      | -    | 62   | °C/W |
| Soldering temperature                | $T_{sold}$                   |      | -    | 260  | °C   |

**•Electronic Characteristics**

| Parameter                         | Symbol       | Condition                     | Min. | Typ. | Max. | Unit       |
|-----------------------------------|--------------|-------------------------------|------|------|------|------------|
| Drain-Source Breakdown Voltage    | $BV_{DSS}$   | $V_{GS}=0V, I_D=250\mu A$     | 40   |      |      | V          |
| Gate Threshold Voltage            | $V_{GS(TH)}$ | $V_{GS}=V_{DS}, I_D=250\mu A$ | 2    | 2.7  | 4    | V          |
| Drain-Source Leakage Current      | $I_{DSS}$    | $V_{GS}=0V, V_{DS}=40V$       |      |      | 1    | $\mu A$    |
| Gate- Source Leakage Current      | $I_{GSS}$    | $V_{GS}=\pm 20V, V_{DS}=0V$   |      |      | 100  | nA         |
| Static Drain-source On Resistance | $R_{DS(ON)}$ | $V_{GS}=10V, I_D=40A$         |      | 1.6  | 2    | m $\Omega$ |
| Forward Transconductance          | $g_{FS}$     | $V_{DS}=5V, I_{SD}=10A$       |      | 30   |      | S          |
| Diode Forward Voltage             | $V_{FSD}$    | $V_{GS}=0V, I_{SD}=40A$       |      |      | 1.3  | V          |

**•Dynamic characteristics**

| Parameter                    | Symbol       | Condition  | Min. | Typ. | Max. | Unit     |
|------------------------------|--------------|--|------|------|------|----------|
| Input capacitance            | $C_{iss}$    | $f=1MHz, V_{DS}=25V$                             | -    | 5430 | -    | pF       |
| Output capacitance           | $C_{oss}$    |  | -    | 1520 | -    |          |
| Reverse transfer capacitance | $C_{rss}$    |  | -    | 84   | -    |          |
| Gate Resistance              | $R_g$        | $f=1MHz$   | -    | 1.6  |      | $\Omega$ |
| Total gate charge            | $Q_g$        | $V_{DD}=15V, I_D=20A, V_{GS}=10V$                | -    | 87   | -    | nC       |
| Gate - Source charge         | $Q_{gs}$     |  | -    | 21   | -    |          |
| Gate - Drain charge          | $Q_{gd}$     |  | -    | 19   | -    |          |
| Turn-ON Delay time           | $t_{D(on)}$  | $V_{GS}=10V, V_{DS}=15V, R_G=3.3\Omega, I_D=20A$ | -    | 15   | -    | ns       |
| Turn-ON Rise time            | $t_r$        |  | -    | 10   | -    | ns       |
| Turn-Off Delay time          | $t_{D(off)}$ |  | -    | 26   | -    | ns       |
| Turn-Off Fall time           | $t_f$        |  | -    | 17   | -    | ns       |
| Reverse Recovery Time        | $t_{RR}$     | $V_{DD}=20V, di_S/dt=100A/\mu s, I_S=50A$        | -    | 65   | -    | ns       |
| Reverse Recovery Charge      | $Q_{RR}$     |  | -    | 95   | -    | nC       |

Fig.1 Gate-Charge Characteristics

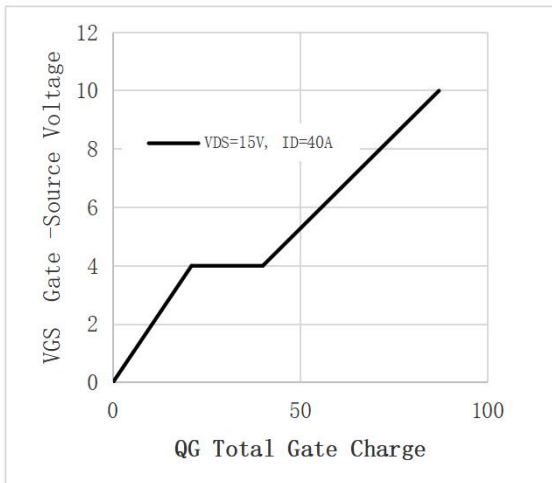


Fig.2 Capacitance Characteristics

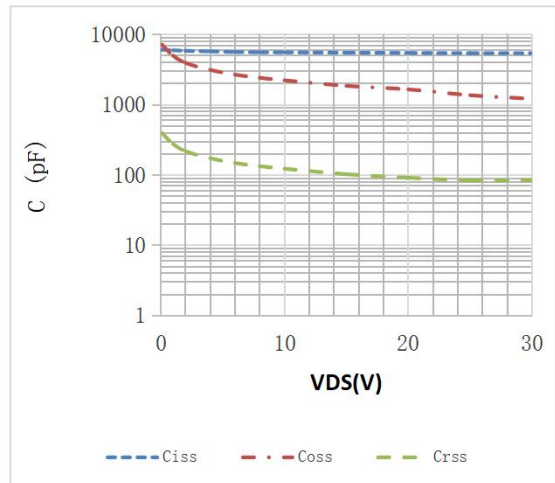


Fig.3 Power Dissipation

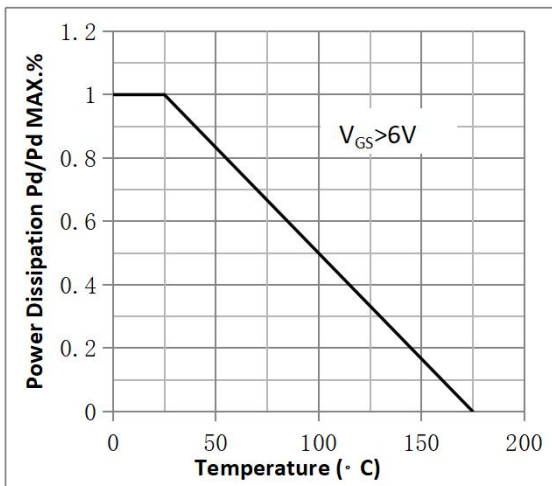


Fig.4 Typical output Characteristics

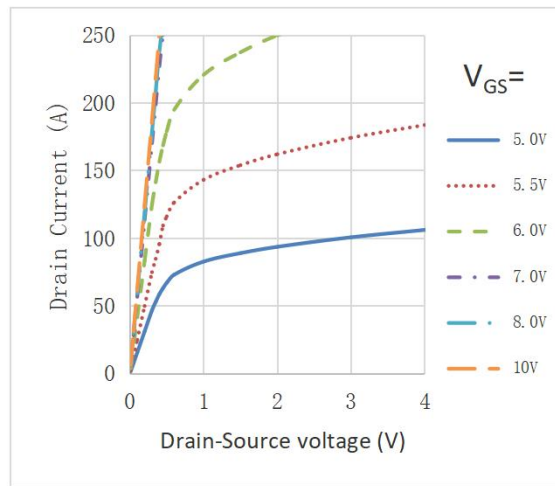


Fig.5 Threshold Voltage V.S Junction Temperature

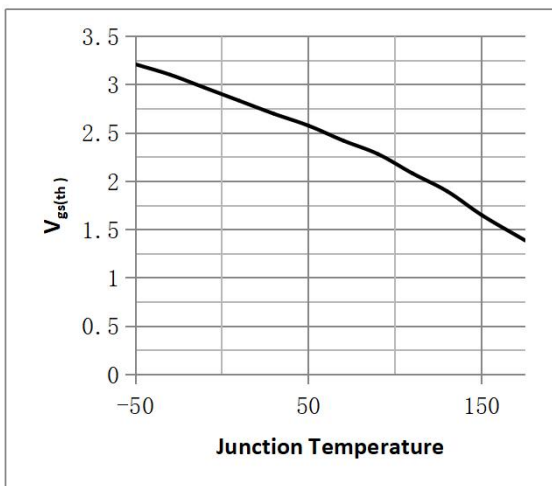


Fig.6 Resistance V.S Drain Current

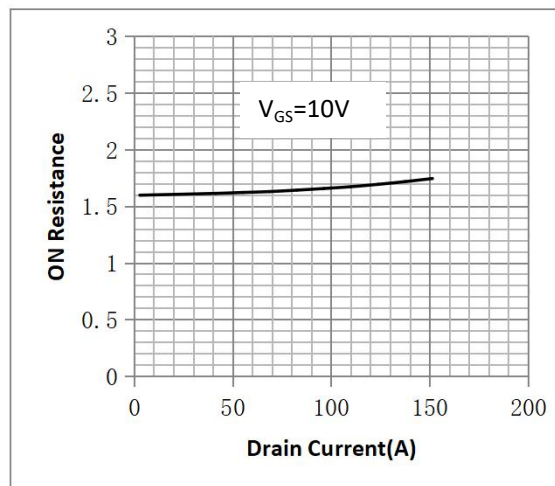


Fig.7 On-Resistance VS Gate Source Voltage

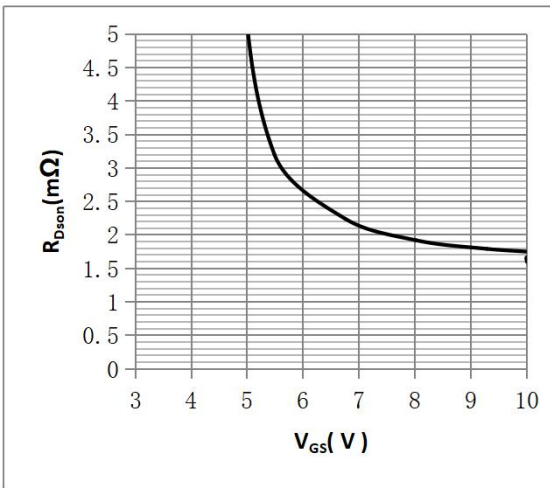


Fig.8 On-Resistance V.S Junction Temperature

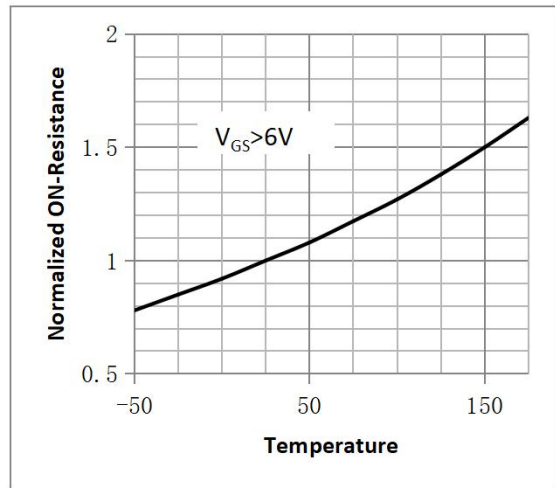


Figure 9. Diode Forward Voltage vs. Current

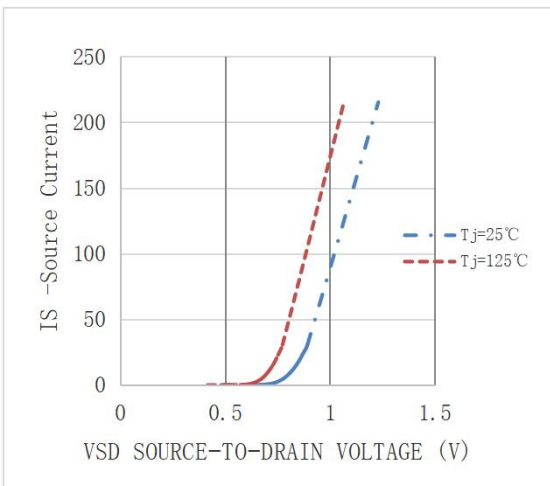


Figure 10. Transfer Characteristics

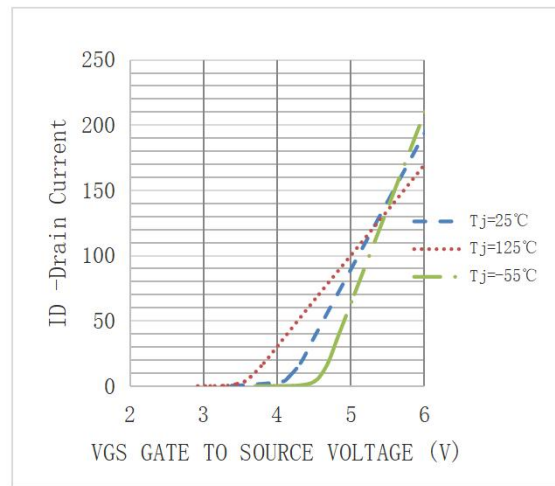


Fig.11 Safe Operating Area

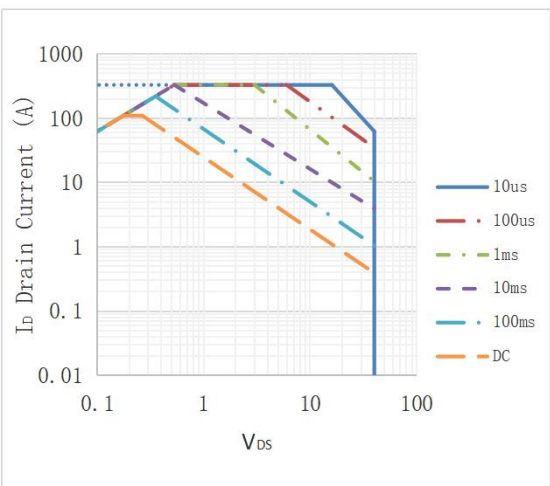
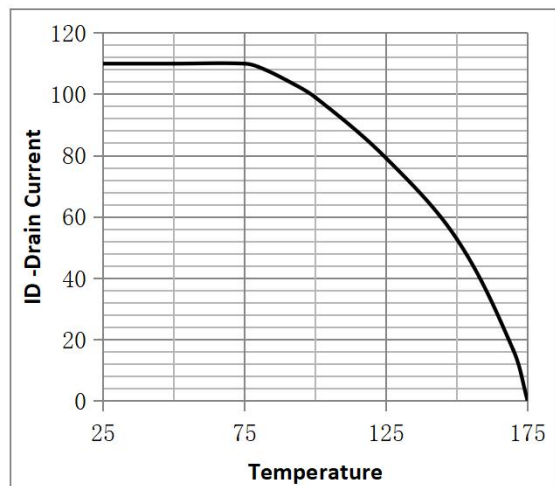
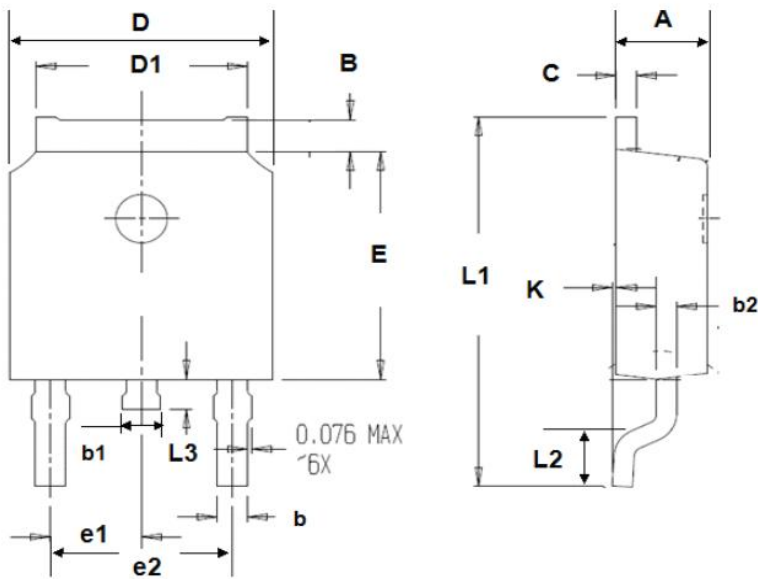


Fig.12 ID vs. Case Temperature



•TO-252 Package Outline

| SYMBOL | min  | max   | SYMBOL | min  | max  |
|--------|------|-------|--------|------|------|
| A      | 2.10 | 2.50  | B      | 0.85 | 1.25 |
| b      | 0.50 | 0.90  | b1     | 0.50 | 0.90 |
| b2     | 0.45 | 0.70  | C      | 0.45 | 0.70 |
| D      | 6.30 | 6.75  | D1     | 5.10 | 5.50 |
| E      | 5.30 | 6.30  | e1     | 2.24 | 2.35 |
| L1     | 9.20 | 10.60 | e2     | 4.43 | 4.75 |
| L2     | 0.90 | 1.75  | L3     | 0.60 | 1.10 |
| K      | 0.00 | 0.23  |        |      |      |



**Note:**

① Pulse Test: Pulse width  $\leq 300\mu\text{s}$ , Duty cycle  $\leq 2\%$ , Accumulation time  $\leq 50$  hours; For DC , the following test conditions can be passed: VGS=+20V/-10V, Tj=175°C, t=1000 hours;

② Device mounted on FR-4 substrate PC board, 2oz copper, with thermal bias to bottom layer 1inch square copper plate;

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Revision History

| Version | Date       | Change  |
|---------|------------|---|
| A       | 2022.1.6   |   |
| B       | 2022.9.4   | 1.Add Reach, HF figure, 2.ID modify<br>2.temperature 265->260°C |
| C       | 2023.12.18 | Correct SOA   |
|         |            |   |
|         |            |   |
|         |            |   |
|         |            |   |
|         |            |   |